Application/Control No. 09/594,302 Examiner David Q Nguyen Applicant(s)/Patent Under Reexamination PAYNE ET AL. Art Unit Page 1 of 1

Notice of References Cited

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,351,523	02-2002	Detlef, Michael John	379/88.14
	В	US-			
	С	US-			
	D	US-	7		
	E	US-			
	F	US-			
	G	US-			-
	Н	US-			
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	х						

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